

<b>Notice of References Cited</b>	Application/Control No. 09/834,165	Applicant(s)/Patent Under Reexamination TANAKA ET AL	
	Examiner Yogesh K. Aggarwal	Art Unit 2615	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,045,932	09-1991	Sharman et al.	358/527
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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**FOREIGN PATENT DOCUMENTS**

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